

PCTEST ENGINEERING LABORATORY, INC.

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HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics MobileComm U.S.A., Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: May 13-15, 2014 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1405070951.ZNF

FCC ID:

ZNFD851

APPLICANT:

LG ELECTRONICS MOBILECOMM U.S.A., INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard: EUT Type: Model(s): Test Device Serial No.: Class II Permissive Change(s): Original Grant Date: RF Emissions Testing Class II Permissive Change §20.19(b) ANSI C63.19-2011 Portable Handset LG-D851, LGD851, D851 *Pre-Production Sample* [S/N: HAC (RFE)] *See FCC Change Document* 05/19/2014

C63.19-2011 HAC Category: M3 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- **RF Electric-field emissions**
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. TEST SITE

2.1 Test Facility / Accreditations:

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Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), Long-Term Evolution (LTE), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and all Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.

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EUT DESCRIPTION 3.



FCC ID: Manufacturer: ZNFD851 LG Electronics MobileComm U.S.A., Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States LG-D851, LGD851, D851 HAC (RFE) Internal Antenna GSM 850, 128, 190, 251, BT Off, WLAN Off, LTE Off GSM 1900, 512, 661, 810, BT Off, WLAN Off, LTE Off Portable Handset

Antenna Configurations: HAC Test Configurations:

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Voice over Digital Transport OTT Capability	WIFI Low Power	Additional GSM Power Reduction
	850	VO	Yes	Yes: WIFI or BT	N/A		
GSM	1900	VO	163		N/A	N/A	No
	GPRS/EDGE	DT	No	Yes: WIFI or BT	Yes		
	850						
UMTS	1700	VD	No²	Yes: WIFI or BT	N/A	N/A	N/A
010113	1900					N/A	N/A
	HSPA	DT	No	Yes: WIFI or BT	Yes		
	700						
LTE	1700	VD	. 12	No ^{1,2} Yes: WIFI or BT	Yes	N/A	N/A
LIE	1900	VD	NO '				
	2500						
	2450						
	5200						
WIFI	5300	DT	No	Yes: GSM, UMTS or LTE	Yes	N/A	N/A
	5500						
	5800						
BT	2450	DT	No	Yes: GSM, UMTS or LTE	N/A	N/A	N/A
Type Transport VO = Voice Only DT = Digital Data	a - Not intended fo			d T-coil measurement has been m 5076 D02 T-Coil testing for CMRS I		guidance issue	d by OET in KDB

EUT Type:

Model(s): Serial Number:

Table 3-1: ZNFD851 HAC Air Interfaces

2. Evaluated for MIF and low-power exemption.

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VD = CMRS and Data Transport

4. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters			
Near field Category	E-field emissions CW dB(V/m)			
	f < 960 MHz			
M1	50 to 55			
M2	45 to 50			
М3	40 to 45			
M4	< 40			
	f > 960 MHz			
M1	40 to 45			
M2	35 to 40			
M3	30 to 35			
M4	< 30			
Table 4-1 WD near-field categories as defined in ANSI C63.19-2011				

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SYSTEM SPECIFICATIONS 5.

ER3DV6 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)
Frequency:	100 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
, ,	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm)
	Tip diameter: 8 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 2.5 mm

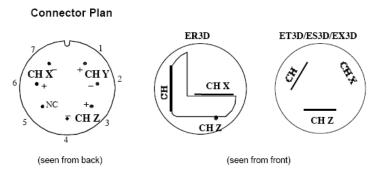


Figure 5-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

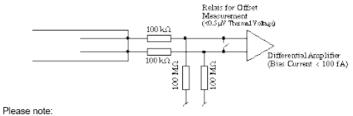
Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

E _l :	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm _i :	sensitivity of channel i in μV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration

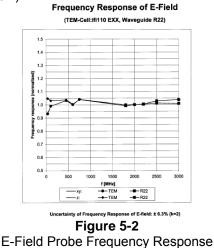


a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).



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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 5-3 SPEAG Robotic System

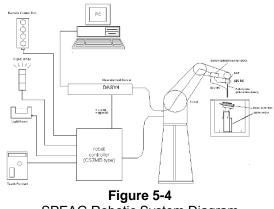
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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with V_i

6. TEST PROCEDURE

I. RF EMISSIONS

Test Instructions

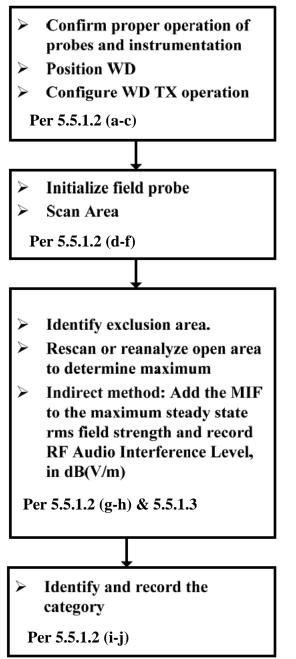
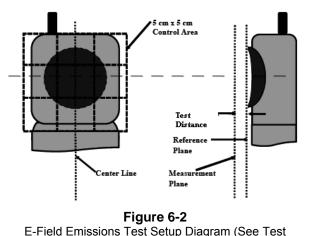


Figure 6-1 RF Emissions Flow Chart

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Test Setup



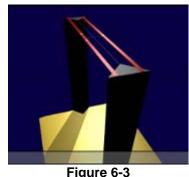


Figure 6-3 HAC Phantom

Photographs for actual WD scan grid overlay)

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

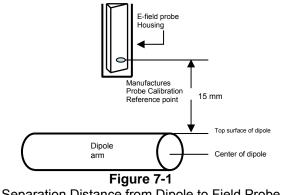
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SYSTEM CHECK 7.

System Check Parameters I.

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

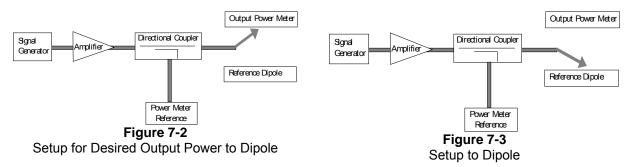
The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

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RF power was recorded using both an average and a peak power reading meter.

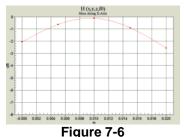


Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 7-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis



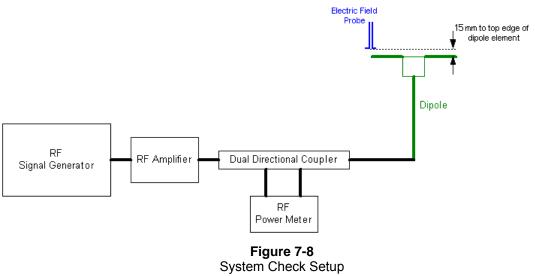
2-D Interpolated points from scan along transverse axis

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III. System Check Results

Validation Results

Frequency (MHz)	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
835	1003	20.0	115.0	107.7	6.7%
1880	1137	20.0	88.6	90.2	-1.8%



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8. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Series No: 10xx:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

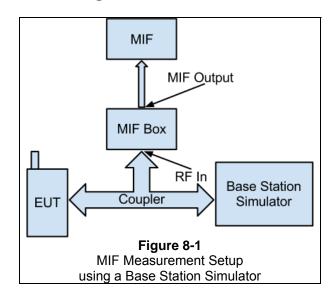
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



III. Measured Modulation Interference Factors:

Band	Channel	GSM [dB] CS (1 Slot)					
	128	3.46					
GSM 850	190	3.46					
	251	3.46					
	512	3.51					
GSM 1900	661	3.50					
	810	3.50					
Table 8-1							

GSM Modulation Interference Factors¹

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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Mode		UMTS V [dB]			UMTS IV [dB]			UMTS II [dB]	
	4132	4183	4233	1312	1412	1862	9262	9400	9538
12.2 kbps RMC	-26.12	-24.67	-20.15	-24.41	-25.89	-25.50	-25.21	-25.08	-24.27
12.2 kbps AMR	-13.16	-13.12	-12.94	-13.53	-13.08	-13.30	-13.36	-13.21	-12.70

Table 8-2 UMTS Modulation Interference Factors¹

Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
17	710	23790	10	16QAM	1	0	-9.69
4	1732.5	20175	20	16QAM	1	0	-10.11
2	1880	18900	20	16QAM	1	0	-9.78
7	2535	21100	10	16QAM	1	0	-11.09
17	710	23790	10	QPSK	1	0	-14.95
17	710	23790	10	16QAM	1	24	-9.62
17	710	23790	10	16QAM	1	49	-9.55
17	710	23790	10	16QAM	25	0	-16.52
17	710	23790	10	16QAM	50	0	-16.21
17	710	23790	5	16QAM	1	0	-10.68

Table 8-3 LTE Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: All LTE bands were found to have substantially similar MIF values given similar RB and BW configurations.

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9. RF CONDUCTED POWER MEASUREMENTS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 9-1 for air interface specific settings of transmit power parameters.

Air Interface:	Parameter Name:	Parameter Set To:						
GSM	PCI	GSM850: "5"						
0.5101	FOL	GSM1900: "0"						
UMTS	TPC	"All 1's"						
LTE	TPC	"Max Power"						
	T 11 64							

Table 9-1

Power Control Parameters and Settings by Air Interface

III. Setup Used to Measure RF Conducted Powers

Power measurements were performed using a base station simulator under digital average power.



Power Measurement Setup

IV. GSM Conducted Powers

Band	Channel	GSM [dBm] CS (1 Slot)
	128	32.61
GSM 850	190	32.67
	251	32.56
	512	30.85
GSM 1900	661	30.79
	810	30.80

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V. UMTS Conducted Powers

Mode	Cellul	ar Band	[dBm]	AWS	6 Band [c	lBm]	PCS	Band [d	Bm]
	4132	4183	4233	1312	1412	1862	9262	9400	9538
12.2 kbps RMC	23.52	23.46	23.67	24.33	24.32	24.34	23.68	23.45	23.40
12.2 kbps AMR	23.50	23.47	23.63	24.32	24.29	24.39	23.64	23.43	23.43

Table 9-2

VI. LTE Conducted Powers

	LTE Band 17 (710MHz) Conducted Powers - 10 MHz Bandwidth										
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]		
	710.0	23790	10	QPSK	1	0	23.92	0	0		
	710.0	23790	10	QPSK	1	25	23.95	0	0		
	710.0	23790	10	QPSK	1	49	24.05	0	0		
	710.0	23790	10	QPSK	25	0	22.66	0-1	1		
	710.0	23790	10	QPSK	25	12	22.60	0-1	1		
	710.0	23790	10	QPSK	25	25	22.58	0-1	1		
Mid	710.0	23790	10	QPSK	50	0	22.65	0-1	1		
Σ	710.0	23790	10	16QAM	1	0	22.48	0-1	1		
	710.0	23790	10	16QAM	1	25	22.46	0-1	1		
	710.0	23790	10	16QAM	1	49	22.53	0-1	1		
	710.0	23790	10	16QAM	25	0	21.42	0-2	2		
	710.0	23790	10	16QAM	25	12	21.41	0-2	2		
	710.0	23790	10	16QAM	25	25	21.45	0-2	2		
	710.0	23790	10	16QAM	50	0	21.52	0-2	2		

Table 9-3 LTE Band 17 (710MHz) Conducted Powers - 5 MHz Bandwidth

	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]	
	710.0	23790	5	QPSK	1	0	23.93	0	0	
	710.0	23790	5	QPSK	1	12	24.00	0	0	
	710.0	23790	5	QPSK	1	24	23.93	0	0	
	710.0	23790	5	QPSK	12	0	22.64	0-1	1	
	710.0	23790	5	QPSK	12	6	22.59	0-1	1	
	710.0	23790	5	QPSK	12	13	22.56	0-1	1	
Mid	710.0	23790	5	QPSK	25	0	22.56	0-1	1	
Σ	710.0	23790	5	16-QAM	1	0	22.43	0-1	1	
	710.0	23790	5	16-QAM	1	12	22.44	0-1	1	
	710.0	23790	5	16-QAM	1	24	22.45	0-1	1	
	710.0	23790	5	16-QAM	12	0	21.44	0-2	2	
	710.0	23790	5	16-QAM	12	6	21.43	0-2	2	
	710.0	23790	5	16-QAM	12	13	21.41	0-2	2	
	710.0	23790	5	16-QAM	25	0	21.43	0-2	2	

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Table 9-4	
LTE Band 4 (1730MHz) Conducted Powers - 20 MHz Bandwidth	

				•••••					
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]
	1732.5	20175	20	QPSK	1	0	24.41	0	0
	1732.5	20175	20	QPSK	1	50	24.30	0	0
	1732.5	20175	20	QPSK	1	99	24.36	0	0
	1732.5	20175	20	QPSK	50	0	23.12	0-1	1
	1732.5	20175	20	QPSK	50	25	23.01	0-1	1
	1732.5	20175	20	QPSK	50	50	23.04	0-1	1
Mid	1732.5	20175	20	QPSK	100	0	23.10	0-1	1
Σ	1732.5	20175	20	16QAM	1	0	22.95	0-1	1
	1732.5	20175	20	16QAM	1	50	22.87	0-1	1
	1732.5	20175	20	16QAM	1	99	22.92	0-1	1
	1732.5	20175	20	16QAM	50	0	22.04	0-2	2
	1732.5	20175	20	16QAM	50	25	21.98	0-2	2
	1732.5	20175	20	16QAM	50	50	22.07	0-2	2
	1732.5	20175	20	16QAM	100	0	22.02	0-2	2

Table 9-5

LTE Band 4 (1730MHz) Conducted Powers - 15 MHz Bandwidth

				01WII 12) 00	naaotoa				
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]
	1717.5	20025	15	QPSK	1	0	24.34	0	0
	1717.5	20025	15	QPSK	1	36	24.33	0	0
	1717.5	20025	15	QPSK	1	74	24.35	0	0
	1717.5	20025	15	QPSK	36	0	23.08	0-1	1
	1717.5	20025	15	QPSK	36	18	23.07	0-1	1
	1717.5	20025	15	QPSK	36	37	23.06	0-1	1
≥	1717.5	20025	15	QPSK	75	0	23.13	0-1	1
Low	1717.5	20025	15	16QAM	1	0	22.86	0-1	1
	1717.5	20025	15	16QAM	1	36	22.90	0-1	1
	1717.5	20025	15	16QAM	1	74	22.91	0-1	1
	1717.5	20025	15	16QAM	36	0	21.95	0-2	2
	1717.5	20025	15	16QAM	36	18	21.93	0-2	2
	1717.5	20025	15	16QAM	36	37	21.95	0-2	2
	1717.5	20025	15	16QAM	75	0	22.00	0-2	2
	1732.5	20175	15	QPSK	1	0	24.40	0	0
	1732.5	20175	15	QPSK	1	36	24.31	0	0
	1732.5	20175	15	QPSK	1	74	24.33	0	0
	1732.5	20175	15	QPSK	36	0	23.10	0-1	1
	1732.5	20175	15	QPSK	36	18	23.07	0-1	1
	1732.5	20175	15	QPSK	36	37	23.13	0-1	1
σ	1732.5	20175	15	QPSK	75	0	23.09	0-1	1
Mid	1732.5	20175	15	16QAM	1	0	23.02	0-1	1
	1732.5	20175	15	16QAM	1	36	22.91	0-1	1
	1732.5	20175	15	16QAM	1	74	22.87	0-1	1
	1732.5	20175	15	16QAM	36	0	21.95	0-2	2
	1732.5	20175	15	16QAM	36	18	21.91	0-2	2
	1732.5	20175	15	16QAM	36	37	21.99	0-2	2
	1732.5	20175	15	16QAM	75	0	22.04	0-2	2
	1747.5	20325	15	QPSK	1	0	24.39	0	0
	1747.5	20325	15	QPSK	1	36	24.38	0	0
	1747.5	20325	15	QPSK	1	74	24.30	0	0
	1747.5	20325	15	QPSK	36	0	23.17	0-1	1
	1747.5	20325	15	QPSK	36	18	23.05	0-1	1
	1747.5	20325	15	QPSK	36	37	23.12	0-1	1
£	1747.5	20325	15	QPSK	75	0	23.21	0-1	1
High	1747.5	20325	15	16QAM	1	0	22.95	0-1	1
	1747.5	20325	15	16QAM	1	36	22.98	0-1	1
	1747.5	20325	15	16QAM	1	74	22.93	0-1	1
	1747.5	20325	15	16QAM	36	0	21.93	0-2	2
	1747.5	20325	15	16QAM	36	18	21.86	0-2	2
	1747.5	20325	15	16QAM	36	37	21.87	0-2	2
	1747.5	20325	15	16QAM	75	0	22.04	0-2	2

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	LTE Band 4 (1730MHz) Conducted Powers - 10 MHz Bandwidth											
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]			
	1715	20000	10	QPSK	1	0	24.33	0	0			
	1715	20000	10	QPSK	1	25	24.34	0	0			
	1715	20000	10	QPSK	1	49	24.36	0	0			
	1715	20000	10	QPSK	25	0	23.09	0-1	1			
	1715	20000	10	QPSK	25	12	23.10	0-1	1			
	1715	20000	10	QPSK	25	25	23.05	0-1	1			
Low	1715	20000	10	QPSK	50	0	23.13	0-1	1			
Lo	1715	20000	10	16QAM	1	0	22.85	0-1	1			
	1715	20000	10	16QAM	1	25	22.86	0-1	1			
	1715	20000	10	16QAM	1	49	22.89	0-1	1			
	1715	20000	10	16QAM	25	0	21.96	0-2	2			
	1715	20000	10	16QAM	25	12	21.95	0-2	2			
	1715	20000	10	16QAM	25	25	21.94	0-2	2			
	1715	20000	10	16QAM	50	0	21.99	0-2	2			
	1732.5	20175	10	QPSK	1	0	24.39	0	0			
	1732.5	20175	10	QPSK	1	25	24.30	0	0			
	1732.5	20175	10	QPSK	1	49	24.35	0	0			
	1732.5	20175	10	QPSK	25	0	23.12	0-1	1			
	1732.5	20175	10	QPSK	25	12	23.06	0-1	1			
	1732.5	20175	10	QPSK	25	25	23.11	0-1	1			
Mid	1732.5	20175	10	QPSK	50	0	23.10	0-1	1			
Σ	1732.5	20175	10	16QAM	1	0	23.00	0-1	1			
	1732.5	20175	10	16QAM	1	25	22.92	0-1	1			
	1732.5	20175	10	16QAM	1	49	22.90	0-1	1			
	1732.5	20175	10	16QAM	25	0	21.96	0-2	2			
	1732.5	20175	10	16QAM	25	12	21.92	0-2	2			
	1732.5	20175	10	16QAM	25	25	21.95	0-2	2			
	1732.5	20175	10	16QAM	50	0	22.01	0-2	2			
	1750	20350	10	QPSK	1	0	24.40	0	0			
	1750	20350	10	QPSK	1	25	24.37	0	0			
	1750	20350	10	QPSK	1	49	24.31	0	0			
	1750	20350	10	QPSK	25	0	23.12	0-1	1			
	1750	20350	10	QPSK	25	12	23.04	0-1	1			
	1750	20350	10	QPSK	25	25	23.10	0-1	1			
High	1750	20350	10	QPSK	50	0	23.20	0-1	1			
Ξ	1750	20350	10	16QAM	1	0	22.92	0-1	1			
	1750	20350	10	16QAM	1	25	22.97	0-1	1			
	1750	20350	10	16QAM	1	49	22.95	0-1	1			
	1750	20350	10	16QAM	25	0	21.94	0-2	2			
	1750	20350	10	16QAM	25	12	21.89	0-2	2			
	1750	20350	10	16QAM	25	25	21.87	0-2	2			
	1750	20350	10	16QAM	50	0	21.99	0-2	2			

Table 9-6 LTE Band 4 (1730MHz) Conducted Powers - 10 MHz Bandwidth

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	LTE Band 4 (1730MHz) Conducted Powers - 5 MHz Bandwidth											
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]			
	1712.5	19975	5	QPSK	1	0	24.32	0	0			
	1712.5	19975	5	QPSK	1	12	24.34	0	0			
	1712.5	19975	5	QPSK	1	24	24.35	0	0			
	1712.5	19975	5	QPSK	12	0	23.10	0-1	1			
	1712.5	19975	5	QPSK	12	6	23.08	0-1	1			
	1712.5	19975	5	QPSK	12	13	23.04	0-1	1			
Low	1712.5	19975	5	QPSK	25	0	23.09	0-1	1			
Lo	1712.5	19975	5	16-QAM	1	0	22.90	0-1	1			
	1712.5	19975	5	16-QAM	1	12	22.91	0-1	1			
	1712.5	19975	5	16-QAM	1	24	22.94	0-1	1			
	1712.5	19975	5	16-QAM	12	0	21.85	0-2	2			
	1712.5	19975	5	16-QAM	12	6	21.89	0-2	2			
	1712.5	19975	5	16-QAM	12	13	21.90	0-2	2			
	1712.5	19975	5	16-QAM	25	0	21.92	0-2	2			
	1732.5	20175	5	QPSK	1	0	24.38	0	0			
	1732.5	20175	5	QPSK	1	12	24.39	0	0			
	1732.5	20175	5	QPSK	1	24	24.36	0	0			
	1732.5	20175	5	QPSK	12	0	23.05	0-1	1			
	1732.5	20175	5	QPSK	12	6	23.08	0-1	1			
	1732.5	20175	5	QPSK	12	13	23.02	0-1	1			
Mid	1732.5	20175	5	QPSK	25	0	23.04	0-1	1			
Σ	1732.5	20175	5	16-QAM	1	0	22.91	0-1	1			
	1732.5	20175	5	16-QAM	1	12	22.95	0-1	1			
	1732.5	20175	5	16-QAM	1	24	22.84	0-1	1			
	1732.5	20175	5	16-QAM	12	0	21.89	0-2	2			
	1732.5	20175	5	16-QAM	12	6	21.90	0-2	2			
	1732.5	20175	5	16-QAM	12	13	21.93	0-2	2			
	1732.5	20175	5	16-QAM	25	0	21.96	0-2	2			
	1752.5	20375	5	QPSK	1	0	24.40	0	0			
	1752.5	20375	5	QPSK	1	12	24.39	0	0			
	1752.5	20375	5	QPSK	1	24	24.37	0	0			
	1752.5	20375	5	QPSK	12	0	23.06	0-1	1			
	1752.5	20375	5	QPSK	12	6	23.10	0-1	1			
	1752.5	20375	5	QPSK	12	13	23.05	0-1	1			
High	1752.5	20375	5	QPSK	25	0	23.07	0-1	1			
Ξ	1752.5	20375	5	16-QAM	1	0	22.92	0-1	1			
	1752.5	20375	5	16-QAM	1	12	22.94	0-1	1			
	1752.5	20375	5	16-QAM	1	24	22.89	0-1	1			
	1752.5	20375	5	16-QAM	12	0	21.91	0-2	2			
	1752.5	20375	5	16-QAM	12	6	21.92	0-2	2			
	1752.5	20375	5	16-QAM	12	13	21.94	0-2	2			
	1752.5	20375	5	16-QAM	25	0	21.97	0-2	2			

Table 9-7 LTE Band 4 (1730MHz) Conducted Powers - 5 MHz Bandwidth

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	LTE Band 2 (1880MHz) Conducted Powers - 20 MHz Bandwidth											
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]			
	1860	18700	20	QPSK	1	0	23.58	0	0			
	1860	18700	20	QPSK	1	50	23.47	0	0			
	1860	18700	20	QPSK	1	99	23.55	0	0			
	1860	18700	20	QPSK	50	0	22.31	0-1	1			
	1860	18700	20	QPSK	50	25	22.32	0-1	1			
	1860	18700	20	QPSK	50	50	22.21	0-1	1			
Low	1860	18700	20	QPSK	100	0	22.30	0-1	1			
Lo	1860	18700	20	16QAM	1	0	22.23	0-1	1			
	1860	18700	20	16QAM	1	50	21.95	0-1	1			
	1860	18700	20	16QAM	1	99	22.05	0-1	1			
	1860	18700	20	16QAM	50	0	21.21	0-2	2			
	1860	18700	20	16QAM	50	25	21.17	0-2	2			
	1860	18700	20	16QAM	50	50	21.16	0-2	2			
	1860	18700	20	16QAM	100	0	21.13	0-2	2			
	1880.0	18900	20	QPSK	1	0	23.51	0	0			
	1880.0	18900	20	QPSK	1	50	23.30	0	0			
	1880.0	18900	20	QPSK	1	99	23.32	0	0			
	1880.0	18900	20	QPSK	50	0	22.12	0-1	1			
	1880.0	18900	20	QPSK	50	25	22.09	0-1	1			
	1880.0	18900	20	QPSK	50	50	22.00	0-1	1			
Mid	1880.0	18900	20	QPSK	100	0	22.08	0-1	1			
Σ	1880.0	18900	20	16QAM	1	0	22.03	0-1	1			
	1880.0	18900	20	16QAM	1	50	21.81	0-1	1			
	1880.0	18900	20	16QAM	1	99	21.83	0-1	1			
	1880.0	18900	20	16QAM	50	0	21.03	0-2	2			
	1880.0	18900	20	16QAM	50	25	21.04	0-2	2			
	1880.0	18900	20	16QAM	50	50	21.02	0-2	2			
	1880.0	18900	20	16QAM	100	0	21.03	0-2	2			
	1900	19100	20	QPSK	1	0	23.36	0	0			
	1900	19100	20	QPSK	1	50	23.56	0	0			
	1900	19100	20	QPSK	1	99	23.42	0	0			
	1900	19100	20	QPSK	50	0	22.14	0-1	1			
	1900	19100	20	QPSK	50	25	22.20	0-1	1			
	1900	19100	20	QPSK	50	50	22.21	0-1	1			
High	1900	19100	20	QPSK	100	0	22.31	0-1	1			
Ξ	1900	19100	20	16QAM	1	0	21.86	0-1	1			
	1900	19100	20	16QAM	1	50	22.02	0-1	1			
	1900	19100	20	16QAM	1	99	21.95	0-1	1			
	1900	19100	20	16QAM	50	0	21.19	0-2	2			
	1900	19100	20	16QAM	50	25	21.21	0-2	2			
	1900	19100	20	16QAM	50	50	21.27	0-2	2			
	1900	19100	20	16QAM	100	0	21.16	0-2	2			

Table 9-8 LTE Band 2 (1880MHz) Conducted Powers - 20 MHz Bandwidth

FCC ID: ZNFD851		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Reviewed by: Quality Manager					
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	LTE Band 2 (1880MHz) Conducted Powers - 15 MHz Bandwidth											
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]			
	1857.5	18675	15	QPSK	1	0	23.52	0	0			
	1857.5	18675	15	QPSK	1	36	23.49	0	0			
	1857.5	18675	15	QPSK	1	74	23.46	0	0			
	1857.5	18675	15	QPSK	36	0	22.31	0-1	1			
	1857.5	18675	15	QPSK	36	18	22.29	0-1	1			
	1857.5	18675	15	QPSK	36	37	22.25	0-1	1			
Low	1857.5	18675	15	QPSK	75	0	22.26	0-1	1			
Lo	1857.5	18675	15	16QAM	1	0	22.01	0-1	1			
	1857.5	18675	15	16QAM	1	36	21.86	0-1	1			
	1857.5	18675	15	16QAM	1	74	21.94	0-1	1			
	1857.5	18675	15	16QAM	36	0	21.19	0-2	2			
	1857.5	18675	15	16QAM	36	18	21.26	0-2	2			
	1857.5	18675	15	16QAM	36	37	21.15	0-2	2			
	1857.5	18675	15	16QAM	75	0	21.14	0-2	2			
	1880.0	18900	15	QPSK	1	0	23.32	0	0			
	1880.0	18900	15	QPSK	1	36	23.28	0	0			
	1880.0	18900	15	QPSK	1	74	23.30	0	0			
	1880.0	18900	15	QPSK	36	0	22.05	0-1	1			
	1880.0	18900	15	QPSK	36	18	22.03	0-1	1			
	1880.0	18900	15	QPSK	36	37	22.06	0-1	1			
Mid	1880.0	18900	15	QPSK	75	0	22.01	0-1	1			
≥	1880.0	18900	15	16QAM	1	0	21.87	0-1	1			
	1880.0	18900	15	16QAM	1	36	21.86	0-1	1			
	1880.0	18900	15	16QAM	1	74	21.84	0-1	1			
	1880.0	18900	15	16QAM	36	0	21.06	0-2	2			
	1880.0	18900	15	16QAM	36	18	21.05	0-2	2			
	1880.0	18900	15	16QAM	36	37	21.04	0-2	2			
	1880.0	18900	15	16QAM	75	0	21.10	0-2	2			
	1902.5	19125	15	QPSK	1	0	23.52	0	0			
	1902.5	19125	15	QPSK	1	36	23.48	0	0			
	1902.5	19125	15	QPSK	1	74	23.51	0	0			
	1902.5	19125	15	QPSK	36	0	22.25	0-1	1			
	1902.5	19125	15	QPSK	36	18	22.31	0-1	1			
	1902.5	19125	15	QPSK	36	37	22.26	0-1	1			
High	1902.5	19125	15	QPSK	75	0	22.27	0-1	1			
Ξ	1902.5	19125	15	16QAM	1	0	22.02	0-1	1			
	1902.5	19125	15	16QAM	1	36	21.95	0-1	1			
	1902.5	19125	15	16QAM	1	74	21.98	0-1	1			
	1902.5	19125	15	16QAM	36	0	21.16	0-2	2			
	1902.5	19125	15	16QAM	36	18	21.20	0-2	2			
	1902.5	19125	15	16QAM	36	37	21.18	0-2	2			
	1902.5	19125	15	16QAM	75	0	21.21	0-2	2			

Table 9-9 LTE Band 2 (1880MHz) Conducted Powers - 15 MHz Bandwidth

FCC ID: ZNFD851		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Reviewed by: Quality Manager					
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					Powers - 10 MHz Bandwidth					
	Frequency	Channel	Bandwidth	Modulation	RB Size	RB Offset	Conducted	MPR Allowed per	MPR [dB]	
	[MHz] 1855	18650	[MHz] 10	QPSK	1	0	Power [dBm] 23.51	3GPP [dB] 0	0	
			10		1	25	23.51	0	0	
	1855	18650	-	QPSK		-		-	-	
	1855	18650	10	QPSK	1	49	23.45	0	0	
	1855	18650	10	QPSK	25	0	22.32	0-1	1	
	1855	18650	10	QPSK	25	12	22.31	0-1	1	
	1855	18650	10	QPSK	25	25	22.26	0-1	1	
Low	1855	18650	10	QPSK	50	0	22.27	0-1	1	
_	1855	18650	10	16QAM	1	0	22.06	0-1	1	
	1855	18650	10	16QAM	1	25	21.87	0-1	1	
	1855	18650	10	16QAM	1	49	21.98	0-1	1	
	1855	18650	10	16QAM	25	0	21.20	0-2	2	
	1855	18650	10	16QAM	25	12	21.24	0-2	2	
	1855	18650	10	16QAM	25	25	21.16	0-2	2	
	1855	18650	10	16QAM	50	0	21.15	0-2	2	
	1880.0	18900	10	QPSK	1	0	23.30	0	0	
	1880.0	18900	10	QPSK	1	25	23.29	0	0	
	1880.0	18900	10	QPSK	1	49	23.27	0	0	
	1880.0	18900	10	QPSK	25	0	22.04	0-1	1	
	1880.0	18900	10	QPSK	25	12	22.06	0-1	1	
	1880.0	18900	10	QPSK	25	25	22.03	0-1	1	
Mid	1880.0	18900	10	QPSK	50	0	22.00	0-1	1	
Σ	1880.0	18900	10	16QAM	1	0	21.89	0-1	1	
	1880.0	18900	10	16QAM	1	25	21.87	0-1	1	
	1880.0	18900	10	16QAM	1	49	21.83	0-1	1	
	1880.0	18900	10	16QAM	25	0	21.01	0-2	2	
	1880.0	18900	10	16QAM	25	12	21.03	0-2	2	
	1880.0	18900	10	16QAM	25	25	21.05	0-2	2	
	1880.0	18900	10	16QAM	50	0	21.09	0-2	2	
	1905	19150	10	QPSK	1	0	23.49	0	0	
	1905	19150	10	QPSK	1	25	23.46	0	0	
	1905	19150	10	QPSK	1	49	23.47	0	0	
	1905	19150	10	QPSK	25	0	22.24	0-1	1	
	1905	19150	10	QPSK	25	12	22.31	0-1	1	
	1905	19150	10	QPSK	25	25	22.28	0-1	1	
ب	1905	19150	10	QPSK	50	0	22.25	0-1	1	
High	1905	19150	10	16QAM	1	0	22.01	0-1	1	
	1905	19150	10	16QAM	1	25	21.94	0-1	1	
	1905	19150	10	16QAM	1	49	21.95	0-1	1	
	1905	19150	10	16QAM	25	0	21.15	0-2	2	
1	1905	19150	10	16QAM	25	12	21.18	0-2	2	
	1905	19150	10	16QAM	25	25	21.17	0-2	2	
	1905	19150	10	16QAM	50	0	21.19	0-2	2	

Table 9-10 LTE Band 2 (1880MHz) Conducted Powers - 10 MHz Bandwidth

FCC ID: ZNFD851		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Reviewed by: Quality Manager					
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	LTE Band 2 (1880MHz) Conducted Powers - 5 MHz Bandwidth										
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]		
	1852.5	18625	5	QPSK	1	0	23.54	0	0		
	1852.5	18625	5	QPSK	1	12	23.48	0	0		
	1852.5	18625	5	QPSK	1	24	23.45	0	0		
	1852.5	18625	5	QPSK	12	0	22.33	0-1	1		
	1852.5	18625	5	QPSK	12	6	22.28	0-1	1		
	1852.5	18625	5	QPSK	12	13	22.25	0-1	1		
Low	1852.5	18625	5	QPSK	25	0	22.24	0-1	1		
Lo	1852.5	18625	5	16-QAM	1	0	22.04	0-1	1		
	1852.5	18625	5	16-QAM	1	12	21.84	0-1	1		
	1852.5	18625	5	16-QAM	1	24	21.94	0-1	1		
	1852.5	18625	5	16-QAM	12	0	21.17	0-2	2		
	1852.5	18625	5	16-QAM	12	6	21.20	0-2	2		
	1852.5	18625	5	16-QAM	12	13	21.13	0-2	2		
	1852.5	18625	5	16-QAM	25	0	21.16	0-2	2		
	1880.0	18900	5	QPSK	1	0	23.33	0	0		
	1880.0	18900	5	QPSK	1	12	23.25	0	0		
	1880.0	18900	5	QPSK	1	24	23.31	0	0		
	1880.0	18900	5	QPSK	12	0	22.09	0-1	1		
	1880.0	18900	5	QPSK	12	6	22.04	0-1	1		
	1880.0	18900	5	QPSK	12	13	22.07	0-1	1		
Mid	1880.0	18900	5	QPSK	25	0	22.01	0-1	1		
Σ	1880.0	18900	5	16-QAM	1	0	21.85	0-1	1		
	1880.0	18900	5	16-QAM	1	12	21.80	0-1	1		
	1880.0	18900	5	16-QAM	1	24	21.81	0-1	1		
	1880.0	18900	5	16-QAM	12	0	21.05	0-2	2		
	1880.0	18900	5	16-QAM	12	6	21.06	0-2	2		
	1880.0	18900	5	16-QAM	12	13	21.07	0-2	2		
	1880.0	18900	5	16-QAM	25	0	21.11	0-2	2		
	1907.5	19175	5	QPSK	1	0	23.50	0	0		
	1907.5	19175	5	QPSK	1	12	23.45	0	0		
	1907.5	19175	5	QPSK	1	24	23.54	0	0		
	1907.5	19175	5	QPSK	12	0	22.26	0-1	1		
	1907.5	19175	5	QPSK	12	6	22.35	0-1	1		
	1907.5	19175	5	QPSK	12	13	22.25	0-1	1		
High	1907.5	19175	5	QPSK	25	0	22.27	0-1	1		
Ξ	1907.5	19175	5	16-QAM	1	0	22.00	0-1	1		
	1907.5	19175	5	16-QAM	1	12	21.91	0-1	1		
	1907.5	19175	5	16-QAM	1	24	21.99	0-1	1		
	1907.5	19175	5	16-QAM	12	0	21.18	0-2	2		
	1907.5	19175	5	16-QAM	12	6	21.22	0-2	2		
	1907.5	19175	5	16-QAM	12	13	21.19	0-2	2		
	1907.5	19175	5	16-QAM	25	0	21.19	0-2	2		

Table 9-11 LTE Band 2 (1880MHz) Conducted Powers - 5 MHz Bandwidth

FCC ID: ZNFD851		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Reviewed by: Quality Manager						
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			Danu 1 (Za	530IVITIZ) C	Powers - 10 MHz Bandwidth					
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]	
	2505	20800	10	QPSK	1	0	23.58	0	0	
	2505	20800	10	QPSK	1	25	23.62	0	0	
	2505	20800	10	QPSK	1	49	23.52	0	0	
	2505	20800	10	QPSK	25	0	22.18	0-1	1	
	2505	20800	10	QPSK	25	12	22.24	0-1	1	
	2505	20800	10	QPSK	25	25	22.30	0-1	1	
Low	2505	20800	10	QPSK	50	0	22.22	0-1	1	
Lo	2505	20800	10	16QAM	1	0	21.96	0-1	1	
	2505	20800	10	16QAM	1	25	21.84	0-1	1	
	2505	20800	10	16QAM	1	49	21.86	0-1	1	
	2505	20800	10	16QAM	25	0	21.06	0-2	2	
	2505	20800	10	16QAM	25	12	21.10	0-2	2	
	2505	20800	10	16QAM	25	25	21.17	0-2	2	
	2505	20800	10	16QAM	50	0	21.07	0-2	2	
	2535.0	21100	10	QPSK	1	0	23.35	0	0	
	2535.0	21100	10	QPSK	1	25	23.42	0	0	
	2535.0	21100	10	QPSK	1	49	23.37	0	0	
	2535.0	21100	10	QPSK	25	0	22.09	0-1	1	
	2535.0	21100	10	QPSK	25	12	22.14	0-1	1	
	2535.0	21100	10	QPSK	25	25	22.06	0-1	1	
Mid	2535.0	21100	10	QPSK	50	0	22.14	0-1	1	
≥	2535.0	21100	10	16QAM	1	0	21.83	0-1	1	
	2535.0	21100	10	16QAM	1	25	21.86	0-1	1	
	2535.0	21100	10	16QAM	1	49	21.83	0-1	1	
	2535.0	21100	10	16QAM	25	0	21.15	0-2	2	
	2535.0	21100	10	16QAM	25	12	21.11	0-2	2	
	2535.0	21100	10	16QAM	25	25	21.70	0-2	2	
	2535.0	21100	10	16QAM	50	0	21.08	0-2	2	
	2565	21400	10	QPSK	1	0	23.43	0	0	
	2565	21400	10	QPSK	1	25	23.47	0	0	
	2565	21400	10	QPSK	1	49	23.60	0	0	
	2565	21400	10	QPSK	25	0	22.16	0-1	1	
	2565	21400	10	QPSK	25	12	22.14	0-1	1	
	2565	21400	10	QPSK	25	25	22.22	0-1	1	
High	2565	21400	10	QPSK	50	0	22.21	0-1	1	
Τ	2565	21400	10	16QAM	1	0	21.90	0-1	1	
	2565	21400	10	16QAM	1	25	21.86	0-1	1	
	2565	21400	10	16QAM	1	49	21.84	0-1	1	
	2565	21400	10	16QAM	25	0	21.05	0-2	2	
	2565	21400	10	16QAM	25	12	21.08	0-2	2	
	2565	21400	10	16QAM	25	25	21.12	0-2	2	
	2565	21400	10	16QAM	50	0	21.07	0-2	2	

Table 9-12 LTE Band 7 (2530MHz) Conducted Powers - 10 MHz Bandwidth

FCC ID: ZNFD851		HAC (RF EMISSIONS) TEST REPORT	🕒 LG	Reviewed by: Quality Manager					
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	LTE Band 7 (2530MHz) Conducted Powers - 5 MHz Bandwidth										
	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]		
	2502.5	20775	5	QPSK	1	0	23.60	0	0		
	2502.5	20775	5	QPSK	1	12	23.58	0	0		
	2502.5	20775	5	QPSK	1	24	23.61	0	0		
	2502.5	20775	5	QPSK	12	0	22.29	0-1	1		
	2502.5	20775	5	QPSK	12	6	22.26	0-1	1		
	2502.5	20775	5	QPSK	12	13	22.32	0-1	1		
Low	2502.5	20775	5	QPSK	25	0	22.29	0-1	1		
Lo	2502.5	20775	5	16-QAM	1	0	22.12	0-1	1		
	2502.5	20775	5	16-QAM	1	12	22.05	0-1	1		
	2502.5	20775	5	16-QAM	1	24	22.12	0-1	1		
	2502.5	20775	5	16-QAM	12	0	21.13	0-2	2		
	2502.5	20775	5	16-QAM	12	6	21.04	0-2	2		
	2502.5	20775	5	16-QAM	12	13	21.09	0-2	2		
	2502.5	20775	5	16-QAM	25	0	21.16	0-2	2		
	2535.0	21100	5	QPSK	1	0	23.57	0	0		
	2535.0	21100	5	QPSK	1	12	23.56	0	0		
	2535.0	21100	5	QPSK	1	24	23.52	0	0		
	2535.0	21100	5	QPSK	12	0	22.24	0-1	1		
	2535.0	21100	5	QPSK	12	6	22.22	0-1	1		
	2535.0	21100	5	QPSK	12	13	22.25	0-1	1		
Mid	2535.0	21100	5	QPSK	25	0	22.24	0-1	1		
Σ	2535.0	21100	5	16-QAM	1	0	22.12	0-1	1		
	2535.0	21100	5	16-QAM	1	12	22.08	0-1	1		
	2535.0	21100	5	16-QAM	1	24	22.10	0-1	1		
	2535.0	21100	5	16-QAM	12	0	21.15	0-2	2		
	2535.0	21100	5	16-QAM	12	6	21.16	0-2	2		
	2535.0	21100	5	16-QAM	12	13	21.17	0-2	2		
	2535.0	21100	5	16-QAM	25	0	21.23	0-2	2		
	2567.5	21425	5	QPSK	1	0	23.53	0	0		
	2567.5	21425	5	QPSK	1	12	23.59	0	0		
	2567.5	21425	5	QPSK	1	24	23.61	0	0		
	2567.5	21425	5	QPSK	12	0	22.30	0-1	1		
	2567.5	21425	5	QPSK	12	6	22.31	0-1	1		
	2567.5	21425	5	QPSK	12	13	22.30	0-1	1		
High	2567.5	21425	5	QPSK	25	0	22.35	0-1	1		
Ξ	2567.5	21425	5	16-QAM	1	0	22.04	0-1	1		
	2567.5	21425	5	16-QAM	1	12	22.07	0-1	1		
	2567.5	21425	5	16-QAM	1	24	22.10	0-1	1		
	2567.5	21425	5	16-QAM	12	0	21.14	0-2	2		
	2567.5	21425	5	16-QAM	12	6	21.12	0-2	2		
	2567.5	21425	5	16-QAM	12	13	21.14	0-2	2		
	2567.5	21425	5	16-QAM	25	0	21.19	0-2	2		

Table 9-13 LTE Band 7 (2530MHz) Conducted Powers - 5 MHz Bandwidth

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10. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

- **a.** According to the April 2013 TCB workshop slides, WIFI and other OTT data services are outside the current definition of a managed CMRS service and are currently not required to be evaluated.
- b. No associated T-coil measurements for VoLTE or VoIP over WIFI CMRS have been made in accordance with the guidance issued by OET in KDB publication 285076 D02 T-Coil testing for CMRS IP.
- c. An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes.

The worst case MIF plus the worst case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required
GSM	32.67	3.51	36.18	Yes
UMTS - RMC	24.34	-20.15	4.19	No
UMTS - AMR	24.39	-12.70	11.69	No
LTE - FDD	24.41	-9.55	14.86	No

II. Individual Mode Evaluations

 Table 10-1

 Max Power + MIF calculations

 for Low Power Exemptions

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice modes. All other air interfaces are exempt.

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11. OVERALL MEASUREMENT SUMMARY

FCC ID:	ZNFD851
Model:	LG-D851, LGD851, D851
S/N:	HAC (RFE)

I. E-FIELD EMISSIONS:

	HAC Data Summary for E-field											
Mode	Channel	Battery Cover ¹	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 5.5
E-field Emis	sions											
GSM850	128	Standard	Acoustic	32.61	35.22	30.94	3.46	34.40	45.00	-10.60	M4	none
GSM850	190	Standard	Acoustic	32.67	38.59	31.73	3.46	35.19	45.00	-9.81	M4	none
GSM850	251	Standard	Acoustic	32.56	44.90	33.05	3.46	36.51	45.00	-8.49	M4	none
GSM1900	512	Standard	Acoustic	30.85	19.72	25.90	3.51	29.41	35.00	-5.59	M4	none
GSM1900	661	Standard	Acoustic	30.79	18.53	25.36	3.50	28.86	35.00	-6.14	M4	none
GSM1900	810	Standard	Acoustic	30.80	19.37	25.74	3.50	29.24	35.00	-5.76	M4	none
GSM1900	512	WC Cover	Acoustic	30.85	20.34	26.17	3.51	29.68	35.00	-5.32	M4	none
GSM1900	512	WC Case: Open	Acoustic	30.85	19.62	25.85	3.51	29.36	35.00	-5.64	M4	none
GSM1900	512	WC Case: Closed	Acoustic	30.85	19.03	25.59	3.51	29.10	35.00	-5.90	M4	none
GSM1900	512	Standard	T-coil	30.85	18.14	25.17	3.51	28.68	35.00	-6.32	M4	none

Table 11-1 HAC Data Summary for E-field

¹ Note: The worst case configuration was retested with the optional battery cover accessories. The additional test cases used the Wireless Charging Battery Cover and the Wireless Charging Case (the latter in both an 'open' and 'closed' configuration) in lieu of the Standard Battery Cover.

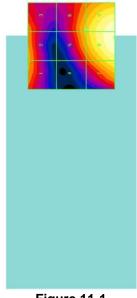


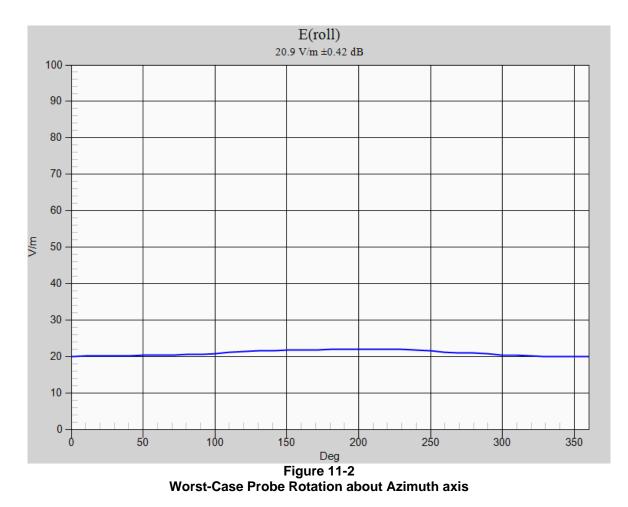
Figure 11-1 Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

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FCC ID:	ZNFD851
Model:	LG-D851, LGD851, D851
S/N:	HAC (RFE)

II. Worst-case Configuration Evaluation

	Table 11-2 Peak Reading 360° Probe Rotation at Azimuth axis									
Battery Scan Time Avg. Time Avg. MIE Interference ECC Limit ECC MARGIN								RESULT		
Probe Rotation at Worst-Case										
GSM1900	512	WC Cover	Acoustic	22.00	26.85	3.51	30.36	35.00	-4.64	M3



* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 11-1 denoted by the green square markers.

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12. EQUIPMENT LIST

Manufacturer	Model	lodel Description		Cal Interval	Cal Due	Serial Number
Agilent	E5515C	Wireless Communications Test Set	10/18/2012	Biennial	10/18/2014	GB43193563
Agilent	E4438C	ESG Vector Signal Generator	4/1/2014	Annual	4/1/2015	MY47270002
Agilent	N5182A	MXG Vector Signal Generator	4/15/2014	Annual	4/15/2015	MY47420651
Agilent	E4407B	ESA Spectrum Analyzer	4/16/2014	Annual	4/16/2015	US39210313
Agilent	E5515C	Wireless Communications Test Set	5/9/2013	Biennial	5/9/2015	GB43304447
Agilent	E5515C	Wireless Communications Test Set	N/A	CBT*	N/A	GB42361078
Amplifier Research	15S1G6	Amplifier	N/A	CBT*	N/A	433977
Anritsu	MT8820C	Radio Communication Analyzer	6/28/2013	Annual	6/28/2014	6201240328
Anritsu	MA2481A	Power Sensor	10/30/2013	Annual	10/30/2014	3681
Anritsu	MA2411B	Pulse Power Sensor	11/14/2013	Annual	11/14/2014	1126066
Anritsu	MT8820C	Radio Communication Analyzer	12/12/2013	Annual	12/12/2014	6201300731
Anritsu	MA24106A	USB Power Sensor	12/18/2013	Annual	12/18/2014	1344545
Anritsu	ML2469A	Power Meter	3/14/2014	Annual	3/14/2015	1306009
Mini-Circuits	BW-N20W5	Power Attenuator	N/A	CBT*	N/A	1226
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	N/A	CBT*	N/A	N/A
Pasternack	PE2209-10	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Pasternack	PE2208-6	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Pasternack	PE2237-20	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Rohde & Schwarz	CMU200	Base Station Simulator	9/23/2013	Annual	9/23/2014	109892
Rohde & Schwarz	NRVD	Dual Channel Power Meter	10/12/2012	Biennial	10/12/2014	101695
Rohde & Schwarz	NRV-Z32	Peak Power Sensor	10/12/2012	Biennial	10/12/2014	836019/013
Rohde & Schwarz	SME06	Signal Generator	10/30/2013	Annual	10/30/2014	832026
Rohde & Schwarz	NRV-Z32	Peak Power Sensor (1mW-20W)	10/31/2013	Annual	10/31/2014	100004
Rohde & Schwarz	NRVS	Single Channel Power Meter	10/31/2013	Annual	10/31/2014	835360/0079
Rohde & Schwarz	NRV-Z32	Peak Power Sensor (100uW-2W)	10/31/2013	Annual	10/31/2014	100155
Rohde & Schwarz	CMW500	LTE Radio Communication Tester	2/20/2014	Annual	2/20/2015	128633
Seekonk	NC-100	Torque Wrench	3/18/2014	Biennial	3/18/2016	N/A
SPEAG	ER3DV6	Freespace E-field Probe	8/23/2013	Annual	8/23/2014	2335
SPEAG	DAE4	Dasy Data Acquisition Electronics	12/20/2013	Annual	12/20/2014	1415
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	2/5/2013	Biennial	2/5/2015	1137
SPEAG	CD835V3	Freespace 835 MHz Dipole	2/5/2013	Biennial	2/5/2015	1003
SPEAG	AIA	Audio Interference Analzyer	N/A	CBT*	N/A	1010

Table 12-1 Equipment List

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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13. MEASUREMENT UNCERTAINTY

Wireless Communications Device Near-Field Measurement Uncertainty Estimation								
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments	
Measurement System								
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB	
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21		
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01		
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14		
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01		
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing	
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*	
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*	
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*	
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*	
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21		
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*	
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*	
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*	
Response Time	0.033	Tolerance	R	1.73	1	0.02	*	
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*	
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*	
Test Sample Related							-	
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*	
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*	
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*	
Power Drift	0.21	Tolerance	R	1.73	1	0.12		
Combined Standard Uncertainty (k=1)						0.66	16.3%	
Expanded Uncertainty [95% confidence]						1.31	32.6%	
Expanded Uncertainty [95% confidence]	on Field					0.66	16.3%	

Table 13-1 Uncertainty Estimation Table

Notes:

- Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All
 equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81
 and NIST Tech Note 1297 and UKAS M3003.
- 2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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TEST DATA 14.

See following Attached Pages for Test Data.

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PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

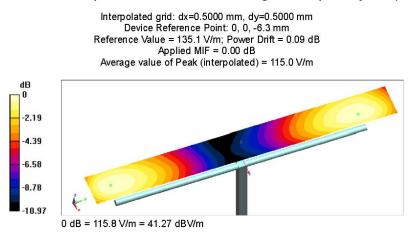
Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/23/2013
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 12/20/2013
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (7);

835 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x361x1):



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DUT: CD1880V3 - SN1137

Type: CD1880V3 Serial: 1137

Communication System: CW; Frequency: 1880 MHz;

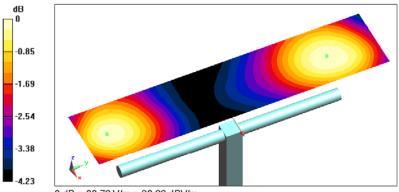
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/23/2013
- Sensor-Surface: 0mm (Fix Surface)
- · Electronics: DAE4 Sn1415; Calibrated: 12/20/2013
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- · Measurement SW: DASY52, Version 52.8 (7);

1880 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 130.0 V/m; Power Drift = -0.14 dB Applied MIF = 0.00 dB Average value of Peak (interpolated) = 88.6 V/m



0 dB = 88.76 V/m = 38.96 dBV/m

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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFD851

Type: Portable Handset Serial: HAC (RFE) Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 848.8 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

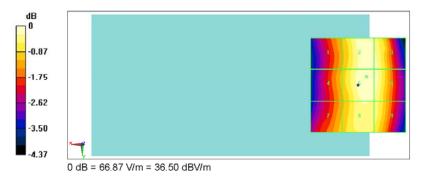
- Probe: ER3DV6 SN2335; Calibrated: 08/23/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 12/20/2013
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (7);

GSM850 High Channel, Standard Battery Cover/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 53.61 V/m; Power Drift = 0.11 dB Applied MIF = 3.46 dB RF audio interference level = 36.51 dBV/m Emission category: M4

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
35.4 dBV/m	36.42 dBV/m	36.35 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.45 dBV/m	36.51 dBV/m	36.4 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
35.51 dBV/m	36.24 dBV/m	36.16 dBV/m



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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFD851

Type: Portable Handset Serial: HAC (RFE) Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1850.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

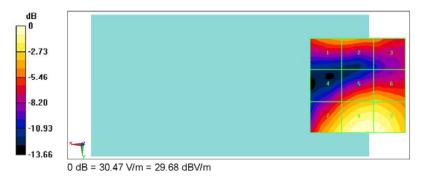
- Probe: ER3DV6 SN2335;Calibrated: 08/23/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1415; Calibrated: 12/20/2013
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (7);

GSM1900 Low Channel, Wireless Charging Battery Cover/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 9.840 V/m; Power Drift = -0.12 dB Applied MIF = 3.51 dB RF audio interference level = 29.68 dBV/m Emission category: M4

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
25.53 dBV/m	25.62 dBV/m	25 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
23.83 dBV/m	26.44 dBV/m	26.46 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
28.16 dBV/m	29.68 dBV/m	29.62 dBV/m



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15. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

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Certificate No: ER3-2335_Aug13 PC Test Client **CALIBRATION CERTIFICATE** ER3DV6 - SN:2335 Object QA CAL-02.v8, QA CAL-25.v6 Calibration procedure(s) Calibration procedure for E-field probes optimized for close near field evaluations in air VcC ansin Calibration date: August 23, 2013 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration Cal Date (Certificate No.) Primary Standards ID Power meter E4419B GB41293874 04-Apr-13 (No. 217-01733) Apr-14 04-Apr-13 (No. 217-01733) Power sensor E4412A MY41498087 Apr-14 04-Apr-13 (No. 217-01737) Apr-14 Reference 3 dB Attenuator SN: S5054 (3c) Reference 20 dB Attenuator SN: S5277 (20x) 04-Apr-13 (No. 217-01735) Apr-14 SN: S5129 (30b) 04-Apr-13 (No. 217-01738) Apr-14 Reference 30 dB Attenuator Reference Probe ER3DV6 SN: 2328 12-Oct-12 (No. ER3-2328_Oct12) Oct-13 15-May-13 (No. DAE4-789_May13) DAE4 SN: 789 May-14 ID Check Date (in house) Scheduled Check Secondary Standards RF generator HP 8648C US3642U01700 In house check: Apr-15 4-Aug-99 (in house check Apr-13) In house check: Oct-13 US37390585 18-Oct-01 (in house check Oct-12) Network Analyzer HP 8753E Function Signature Name Calibrated by: Leif Klysner Laboratory Technician Approved by: Katja Pokovic Technical Manager Issued: August 23, 2013 This calibration certificate shall not be reproduced except in full without written approval of the laboratory Certificate No: ER3-2335_Aug13 Page 1 of 10

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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

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Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization 9	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
 b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). •
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal ٠ characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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Probe ER3DV6

SN:2335

Manufactured: Calibrated: September 9, 2003 August 23, 2013

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

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ER3DV6- SN:2335

August 23, 2013

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	1.64	1.70	1.87	± 10.1 %
DCP (mV) ^B	97.7	98.6	100.6	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	152.3	±2.7 %
		Y	0.0	0.0	1.0		163.1	
		Z	0.0	0.0	1.0		191.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.
 ^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

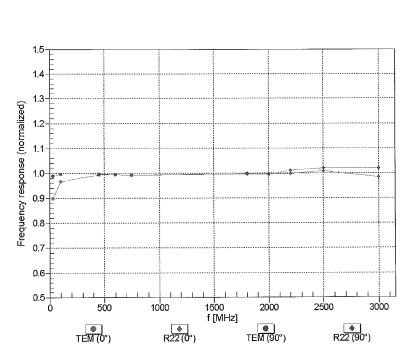
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ER3DV6- SN:2335

August 23, 2013



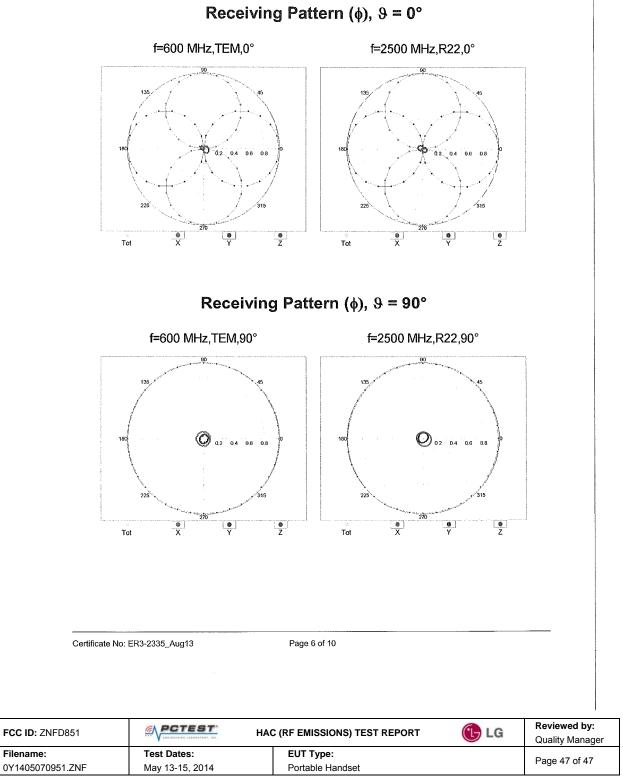
Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)

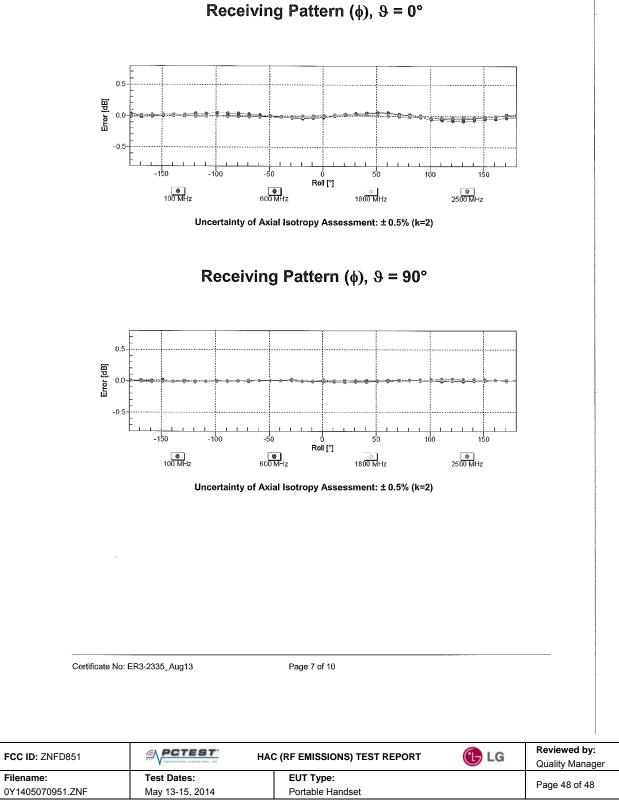
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

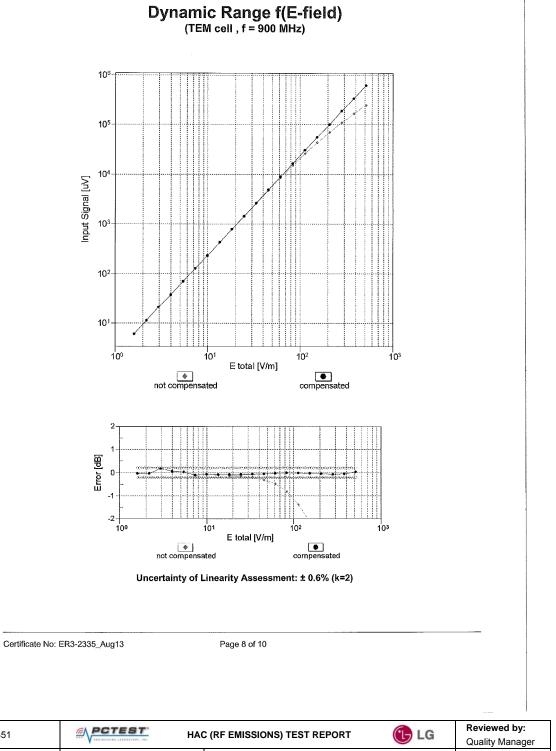
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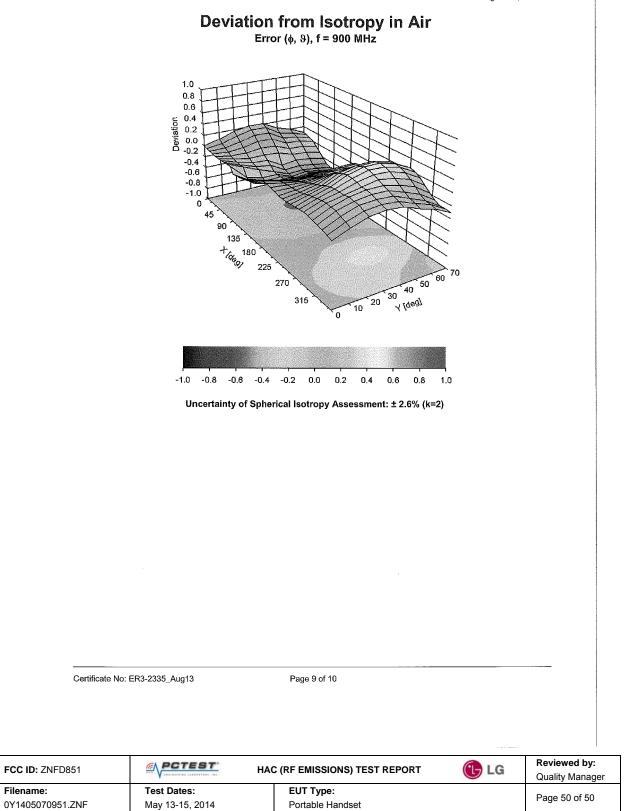




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ER3DV6- SN:2335

August 23, 2013



ER3DV6- SN:2335

August 23, 2013

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-99
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

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Client PC Test

Certificate No: CD835V3-1003_Feb13

Object	CD835V3 - SN:	1003 - ^{Elimen} Schellersen, billing Schell (1995).	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	edure for dipoles in air	
			an an taobh ann an Anna
Calibration date:	February 05, 20	13 Mariana Mariana ang kanalari na kana Na kanalari na k	× 404 13
The measurements and the une All calibrations have been condu	ertainties with confidence p ucted in the closed laborate	tional standards, which realize the physical uniprobability are given on the following pages an bry facility: environment temperature $(22 \pm 3)^{\circ}$	d are part of the certificate.
Calibration Equipment used (M8	TE critical for calibration)		
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	01-Nov-12 (No. 217-01640)	Oct-13
Power sensor HP 8481A	US37292783	01-Nov-12 (No. 217-01640)	Oct-13
Reference 10 dB Attenuator	SN: 5047.2 (10q)	27-Mar-12 (No. 217-01527)	Apr-13
Probe ER3DV6	SN: 2336	28-Dec-12 (No. ER3-2336_Dec12)	Dec-13
Probe H3DV6	SN: 6065	28-Dec-12 (No. H3-6065_Dec12)	Dec-13
DAE4	SN: 781	29-May-12 (No. DAE4-781_May12)	May-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-12)	In house check: Oct-13
Power sensor HP E4412A	SN: MY41495277	01-Apr-08 (in house check Oct-12)	In house check: Oct-13
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-12)	In house check: Oct-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-12)	In house check: Oct-13
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-12)	In house check: Oct-14
	Name	Function	Signature
Calibrated by:	Dimce Illev	Laboratory Technician	D. Liev
Approved by:	Katja Pokovic	Technical Manager	Jel lly
			*
			Issued: February 6, 2013
	not be reproduced except i	in full without written approval of the laboratory	

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References

- [1] ANSI-C63.19-2007
 - American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.5
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm 15mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.470 A / m ± 8.2 % (k=2)
E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	169.8 V / m
Maximum measured above low end	100 mW input power	164.4 V / m
Averaged maximum above arm	100 mW input power	167.1 V / m ± 12.8 % (k=2)
E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	108.3 V / m
Maximum measured above low end	100 mW input power	107.0 V / m
Averaged maximum above arm	100 mW input power	107.7 V / m ± 12.8 % (k=2)

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Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.1 dB	41.2 Ω - 11.5 jΩ
835 MHz	26.6 dB	51.6 Ω + 4.5 jΩ
900 MHz	16.6 dB	57.8 Ω - 14.1 jΩ
950 MHz	18.8 dB	52.6 Ω + 11.6 jΩ
960 MHz	13.7 dB	63.4 Ω + 19.5 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals. Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be

damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

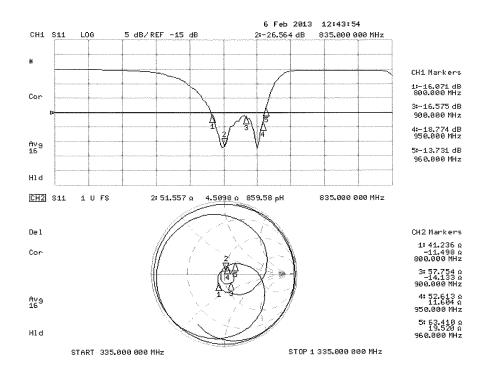
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 H-field Result

Date: 05.02.2013

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

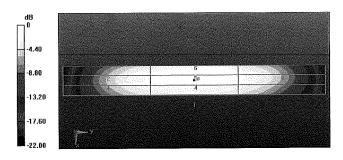
DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 28.12.2012 6
- Sensor-Surface: (Fix Surface) 0
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012 •
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070 .
- e DASY52 52.8.5(1059); SEMCAD X 14.6.8(7028)

Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.4980 A/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.4697 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 0.380 A/m		
Grid 4 M4 0.427 A/m		
Grid 7 M4 0.369 A/m	Grid 8 M4 0.413 A/m	Grid 9 M4 0.406 A/m



0 dB = 0.4697 A/m = -6.56 dBA/m

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DASY5 E-field Result

Date: 05.02.2013

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 28.12.2012;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.5(1059); SEMCAD X 14.6.8(7028)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 112.7 V/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 169.8 V/m Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

	Grid 2 M4 164.4 V/m	
Grid 4 M4 86.08 V/m		
Grid 7 M4 155.8 V/m		

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid

Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 112.1 V/m; Power Drift = -0.03 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 108.3 V/m

Near-field category: M4 (AWF 0 dB)

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PMF scaled E-	field	
Grid 1 M4 105.2 V/m		
Grid 4 M4 62.40 V/m		

Grid 7 M4 Grid 8 M4 Grid 9 M4 104.3 V/m 108.3 V/m 107.9 V/m

dB D				
-2.55				
-5.11	3	e e	9 8 8	
-7.66	<u>≋∎</u> 2 1			
-10.22				
-12.77	τ			

0 dB = 169.8 V/m = 44.60 dBV/m

Certificate No: CD835V3-1003_Feb13

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Certificate No: CD1880V3-1137_Feb13

Accreditation No.: SCS 108

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Client PC Test

CALIBRATION CERTIFICATE CD1880V3 - SN: 1137 Object QA CAL-20.v6 Calibration procedure(s) Calibration procedure for dipoles in air February 05, 2013 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) ID # Cal Date (Certificate No.) Scheduled Calibration Primary Standards Oct-13 GB37480704 01-Nov-12 (No. 217-01640) Power meter EPM-442A Oct-13 01-Nov-12 (No. 217-01640) Power sensor HP 8481A US37292783 Apr-13 Reference 10 dB Attenuator SN: 5047.2 (10q) 27-Mar-12 (No. 217-01527) SN: 2336 28-Dec-12 (No. ER3-2336_Dec12) Dec-13 Probe ER3DV6 28-Dec-12 (No. H3-6065_Dec12) Dec-13 Probe H3DV6 SN: 6065 29-May-12 (No. DAE4-781_May12) May-13 DAE4 SN: 781 Scheduled Check ID # Check Date (in house) Secondary Standards SN: GB42420191 09-Oct-09 (in house check Oct-12) In house check: Oct-13 Power meter Agilent 4419B In house check: Oct-13 SN: MY41495277 01-Apr-08 (in house check Oct-12) Power sensor HP E4412A SN: US37295597 09-Oct-09 (in house check Oct-12) In house check: Oct-13 Power sensor HP 8482A 18-Oct-01 (in house check Oct-12) In house check: Oct-13 Network Analyzer HP 8753E US37390585 In house check: Oct-14 RF generator R&S SMT-06 SN: 832283/011 27-Aug-12 (in house check Oct-12) Signature Name Function Dimce Iliev Laboratory Technician Calibrated by: Approved by: Katja Pokovic Technical Manager Issued: February 6, 2013 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD1880V3-1137_Feb13

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References

[1] ANSI-C63.19-2007

- American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011
- American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC rest Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuring the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.5
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm 15mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.493 A / m ± 8.2 % (k=2)
E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	154.1 V / m
Maximum measured above low end	100 mW input power	150.3 V / m
Averaged maximum above arm	100 mW input power	152.2 V / m ± 12.8 % (k=2)
E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	98.6 V / m
Maximum measured above low end	100 mW input power	97.6 V / m
Averaged maximum above arm	100 mW input power	98.1 V / m ± 12.8 % (k=2)

Maximum Field values at 1880 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.467 A / m ± 8.2 % (k=2)
E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	140.1 V / m
Maximum measured above low end	100 mW input power	139.2 V / m
Averaged maximum above arm	100 mW input power	139.7 V / m ± 12.8 % (k=2)
E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	91.7 V / m
Maximum measured above low end	100 mW input power	88.7 V / m
Averaged maximum above arm	100 mW input power	90.2 V / m ± 12.8 % (k=2)

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Appendix

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance
1730 MHz	22.1 dB	48.6 Ω + 7.7 jΩ
1880 MHz	20.4 dB	50.2 Ω + 9.6 jΩ
1900 MHz	21.0 dB	53.6 Ω + 8.5 jΩ
1950 MHz	27.3 dB	54.5 Ω + 0.0 jΩ
2000 MHz	20.1 dB	41.0 Ω - 1.2 jΩ

Additional Frequencies

Frequency	Return Loss	Impedance
1730 MHz	22.1 dB	48.6 Ω + 7.7 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

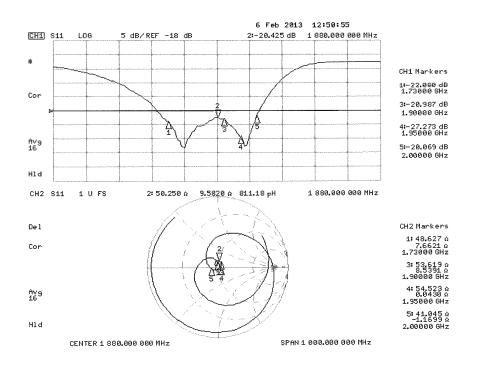
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 H-field Result

Date: 05.02.2013

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: CW; Frequency: 1730 MHz, Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_c = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 28.12.2012
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.5(1059); SEMCAD X 14.6.8(7028)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1730MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.5230 A/m; Power Drift = -0.02 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.4933 A/m Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2 0.406 A/m	Grid 2 M2 0.437 A/m	Grid 3 M2 0.425 A/m
Grid 4 M2 0.453 A/m		
Grid 7 M2 0.394 A/m		

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.4940 A/m; Power Drift = 0.02 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.4674 A/m

Near-field category: M2 (AWF 0 dB)

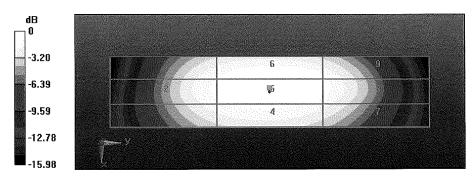
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PMF scaled H-field

Grid 1 M2 0.404 A/m	Grid 3 M2 0.418 A/m
Grid 4 M2 0.436 A/m	
Grid 7 M2 0.393 A/m	Grid 9 M2 0.417 A/m



0 dB = 0.4933 A/m = -6.14 dBA/m

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DASY5 E-field Result

Date: 05.02.2013

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: CW; Frequency: 1730 MHz, Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 28.12.2012;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.5(1059); SEMCAD X 14.6.8(7028)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 167.8 V/m; Power Drift = -0.03 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 154.1 V/m Near-field category: M2 (AWF 0 dB)

PMF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
143.6 V/m	150.3 V/m	148.3 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
99.24 V/m	103.5 V/m	100.7 V/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
141.6 V/m	154.1 V/m	153.3 V/m

Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm

Reference Value = 167.4 V/m; Power Drift = 0.00 dB PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 98.59 V/m Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
95.62 V/m	98.59 V/m	97.71 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
75.59 V/m	77.10 V/m	76.15 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
93.67 V/m	97.64 V/m	97.16 V/m

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Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 152.4 V/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 140.1 V/m Near-field category: M2 (AWF 0 dB)

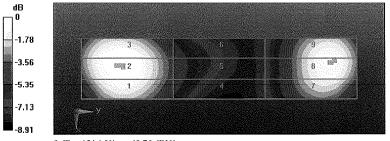
PMF scaled E-field				
Grid 1 M2	Grid 2 M2	Grid 3 M2		
133.0 V/m	139.2 V/m	137.5 V/m		
Grid 4 M3	Grid 5 M3			
Grid 7 M2	Grid 8 M2	Grid 9 M2		
128.4 V/m	140.1 V/m	139.5 V/m		

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm

Reference Value = 152.6 V/m; Power Drift = -0.03 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 91.71 V/m Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

Grid 1 M3 89.14 V/m	
Grid 4 M3 69.64 V/m	
Grid 7 M3 85.07 V/m	



0 dB = 154.1 V/m = 43.76 dBV/m

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16. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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